

Notice of References Cited

Application No.

10/030682

Applicant(s)

Ohno et al

Examiner

Langel

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*	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
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NON-PATENT DOCUMENTS

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U	Abstract of Japanese 355116624A.	9-8-80
V	Abstract of European 000345354A1	12-13-89
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(See Manual of Patent Examining Procedure, Section 707.05(a).)